

DESCRIPTION:

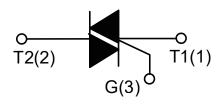
With high ability to withstand the shock loading of large current, BTA204W-600E series triacs provide high dv/dt rate with strong resistance to electromagnetic interface. With high commutation performances, 3 quadrants products especially recommended for use on inductive load.



SOT-223

MAIN FEATURES

Symbol	Value	Unit
V _{DRM} /V _{RRM}	600/800	V
I _{T(RMS)}	1	А



ABSOLUTE MAXIMUM RATINGS

Para	meter	Symbol	Value	Unit
Storage junction temperature range		T _{stg}	-40 - 150	$^{\circ}\mathbb{C}$
Operating junction temperature range		Tj	-40 - 125	$^{\circ}$ C
Repetitive peak off-sta	Repetitive peak off-state voltage (T _j =25℃)		600/800	V
Repetitive peak reverse voltage (T _j =25℃)		V _{RRM}	600/800	V
RMS on-state current	SOT-223/ SOT-223-2L (Tc=70°C)	I _{T(RMS)}	1	А
Non repetitive surge peak on-state current (full cycle, F=50Hz)		Ітѕм	25	А
I ² t value for fusing (tp=10ms)		l ² t	3.1	A ² s
Critical rate of rise of on-state current (I _G =2×I _{GT})		dl/dt	50	A/µs
Peak gate current		I _{GM}	1	Α
Average gate power dissipation		P _{G(AV)}	0.1	W
Peak gate power		P _{GM}	0.5	W



ELECTRICAL CHARACTERISTICS (T_j =25 $^{\circ}$ C unless otherwise specified)

Symbol	Test Condition	n Quadrant	Value			Unit		
Symbol	rest Condition			TW	sw	CW	BW	Offic
lgт	V _D =12V R _L =33Ω	I - II -III	MAX	5	10	35	50	mA
V _G T	VD-12V KL-3322	I - II -III	MAX	1.3				V
V _{GD}	$V_D = V_{DRM} T_j = 125$ °C RL = 3.3KΩ	I - II -III	MIN	0.2		V		
IL	1 -4 01	I -III	10	20	50	70	mA	
"L	I _G =1.2I _{GT}	II	MAX	15	35	60	80	IIIA
Ін	I _T =100mA		MAX	10	15	35	60	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	50	100	500	1000	V/µs

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
V _{TM}	I _{TM} =5.5A tp=380µs	T _j =25℃	1.5	V
IDRM	V _D =V _{DRM} V _R =V _{RRM}	T _j =25℃	10	μΑ
I _{RRM}		Tj=125℃	0.75	mA

THERMAL RESISTANCES

Symbol	Parameter		Value	Unit
$R_{th(j-c)}$	junction to case(AC)	SOT-223/	4.1	°C/W
R _{th(j-a)}	junction to ambient	SOT-223-2L	60	C/VV



FIG.1: Maximum power dissipation versus RMS on-state current

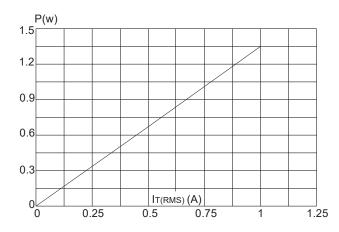


FIG.2: RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness:35 μ m)(full cycle) $_{\text{IT(RMS)}}$ (A)

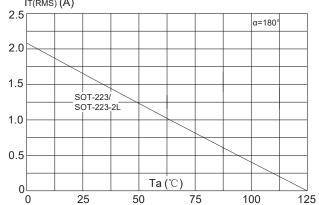




FIG.3: Surge peak on-state current versus number of cycles

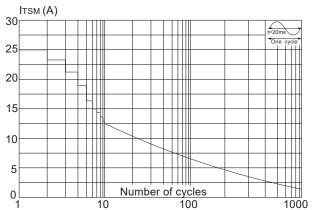


FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<20ms and corresponding value of I²t (dI/dt < 50A/µs)

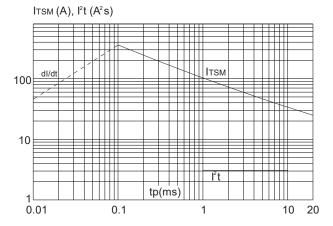


FIG.4: On-state characteristics (maximum values)

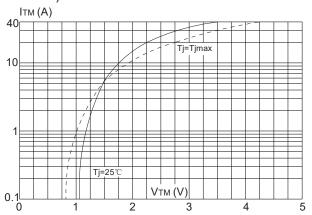
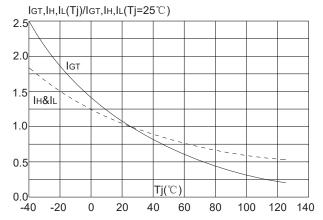


FIG.6: Relative variations of gate trigger current, holding current and latching current versus junction temperature





SOLDERING PARAMETERS

Reflow Condition		Pb-Free assembly	
		(see figure at right)	
	-Temperature Min (T _{s(min)})	+150℃	
Pre Heat	-Temperature Max(T _{s(max)})	+200℃	
	-Time (Min to Max) (ts)	60-180 secs.	
Average ramp up rate (Liquidus Temp (T _L)to peak)		3℃/sec. Max	
$T_{s(max)}$ to T_L - Ramp-up Rate		3℃/sec. Max	
Reflow	-Temperature(T _L)(Liquidus)	+217℃	
Kellow	-Temperature(t∟)	60-150 secs.	
Peak Ten	np (T _p)	+260(+0/-5)°C	
Time with Peak Ten	in 5°Cof actual np (t _p)	20-40secs.	
Ramp-do	wn Rate	6°C/sec. Max	
Time 25°	to Peak Temp (T _P)	8 min. Max	
Do not ex	ceed	+260℃	

